

# PRODUCT UPDATE ANNOUNCEMENT

**FLUKE**<sup>®</sup>

Date: May 3, 2011

## Thermal Sensitivity (NETD) Performance Enhancement for Fluke Ti32 and TiR32

Fluke is pleased to announce a **thermal sensitivity (NETD) performance enhancement** for the already industry-leading Ti32 and TiR32 Thermal Imagers.

### Fluke Ti32 Thermal Imager

- Thermal Sensitivity (NETD) Improvement: now  $\leq 45\text{mK}$  ( $0.045\text{ }^{\circ}\text{C}$ )

### Fluke TiR32 Thermal Imager

- Thermal Sensitivity (NETD) Improvement: now  $\leq 40\text{mK}$  ( $0.040\text{ }^{\circ}\text{C}$ )

These improvements will be implemented on all Ti32 and TiR32 thermal imagers **beginning approximately June 15<sup>th</sup>, 2011**.

There is not presently an ability to broadly update performance and features on existing or older models. However, when imagers return for calibration or repair, the Fluke Service department makes every attempt to update and upgrade existing thermal imagers to the highest level of performance supported by specific hardware configurations.

If you have questions regarding any of the information in this announcement, please do not hesitate to contact me.

Thank you for your time and attention.

Best regards,



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